Search Notes



10541454

Applicant(s)/Patent Under Reexamination

YOSHIMURA ET AL.

Examiner Alain L Bashore Art Unit

1792

SEARCHED

Class	Subclass	Date	Examiner
427	127, 131,132	12-1-08	ab
428	323, 570	12-1-08	ab

SEARCH NOTES

Search Notes	Date	Examiner
EAST (attached)	12-1-08	ab
eDan inventor search	12-1-08	ab
previous search updated	6-8-09	ab
inventor, EAST search (updated)	1/26/2010	ML
inventor, EAST search (updated)	10/18/2010	ML

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

/M. C. L./ Examiner.Art Unit 1792

/Alain L Bashore/ Primary Examiner.Art Unit 1792

U.S. Patent and Trademark Office Part of Paper No.: 20101020